

Two-Tone Signal Generation for Communication Application ADC Testing

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Outline

- Research Background
- Conventional Method
- Proposed Method
- Experimental Results
- Conclusion

Outline

- Research Background

Research Background

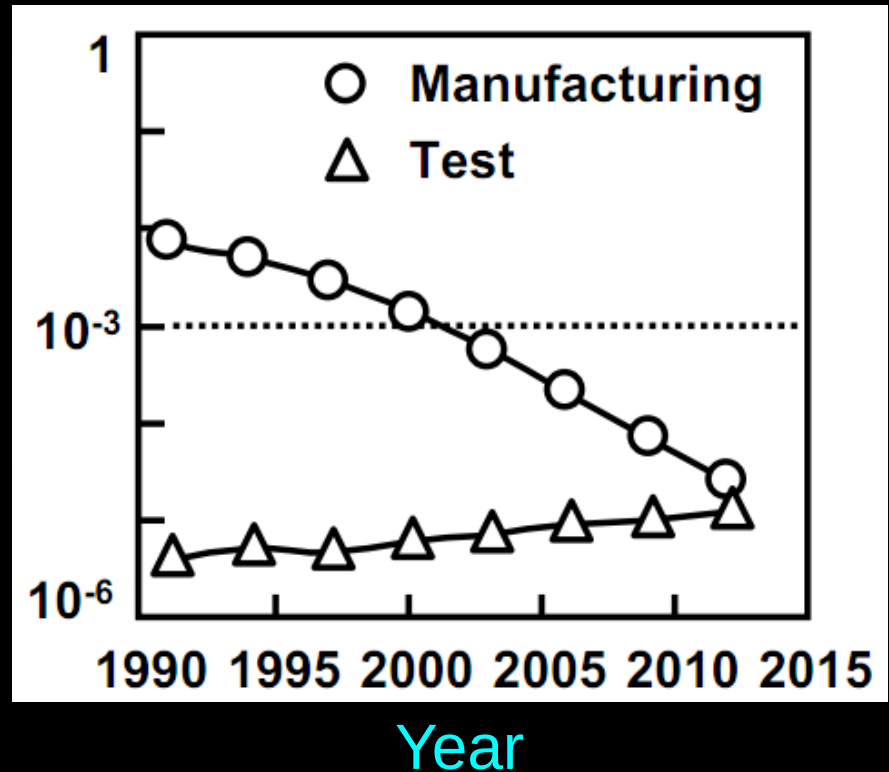
Mixed signal SoC, communication devices

➔ Analog digital converter (ADC) is key component

Manufacturing cost ➔ Lower
Test cost ➔ Higher

Need for low cost test

Cost (Cents / Transistor)

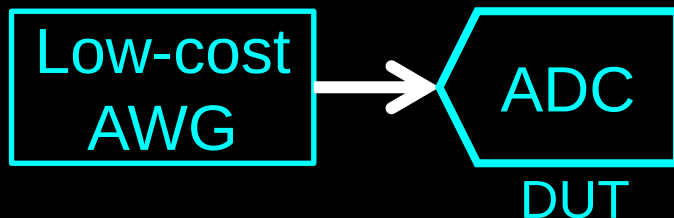


Cost of test trend
(ITRS 2001)

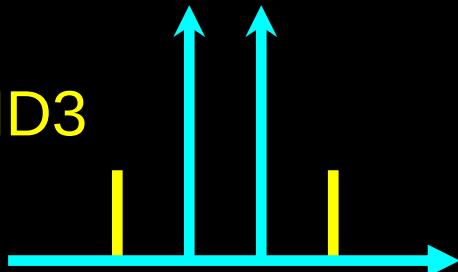
Research Goal

Low distortion two-tone signal generation
for communication application ADC testing
with low-cost AWG

Conventional method



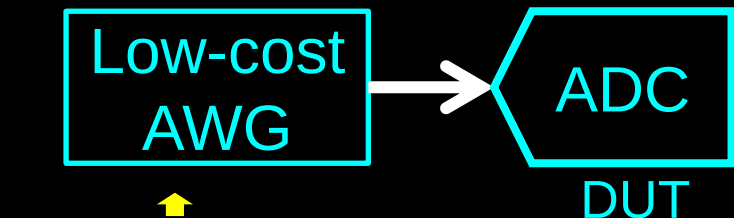
IMD3



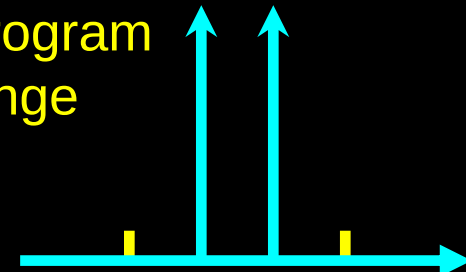
Low SFDR ☹️

AWG : Arbitrary Waveform Generator

Proposed method



DSP program
change



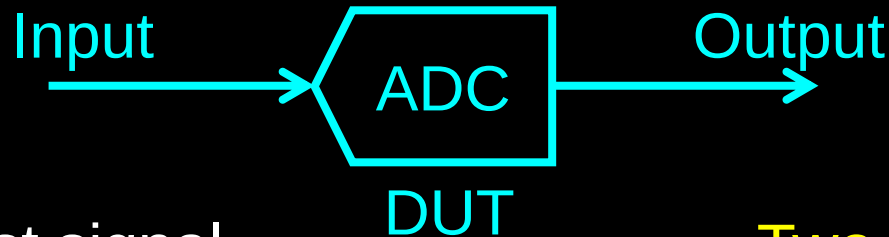
High SFDR 😊

SFDR : Spurious-Free Dynamic Range 5/32

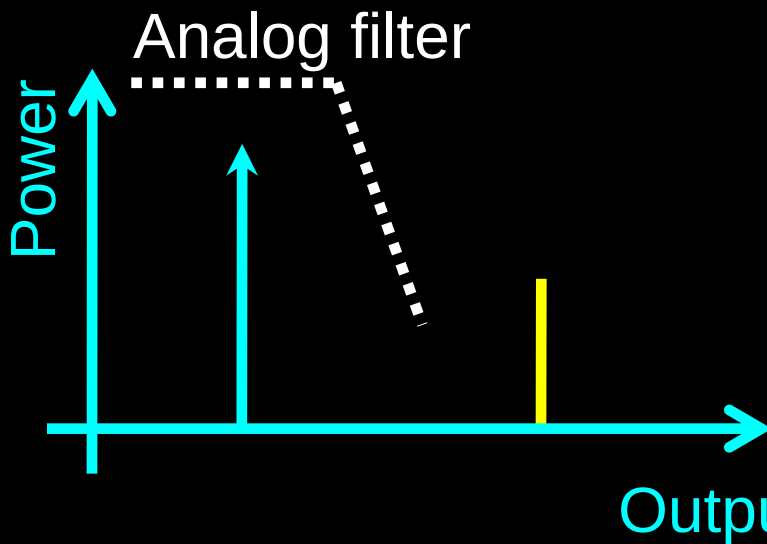
Need for Two-tone Test Signal

Communication application ADC

➔ Receive narrow band & high frequency signal

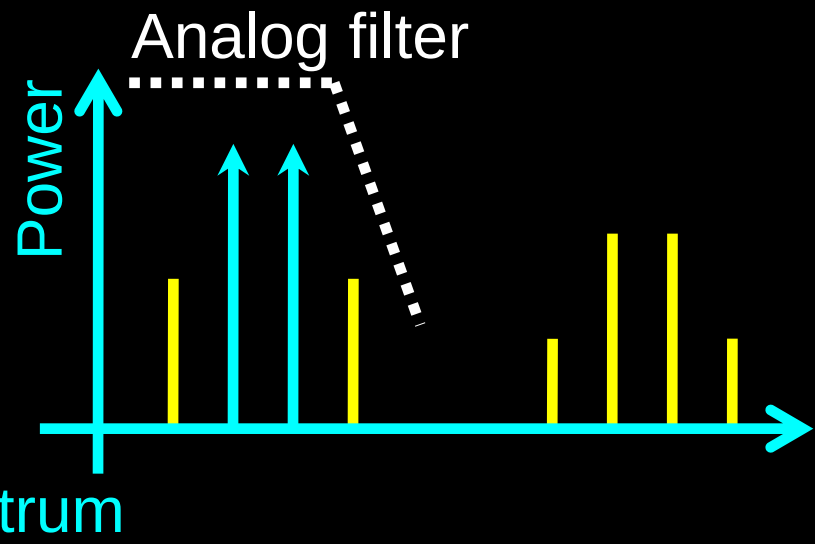


Single-tone test signal



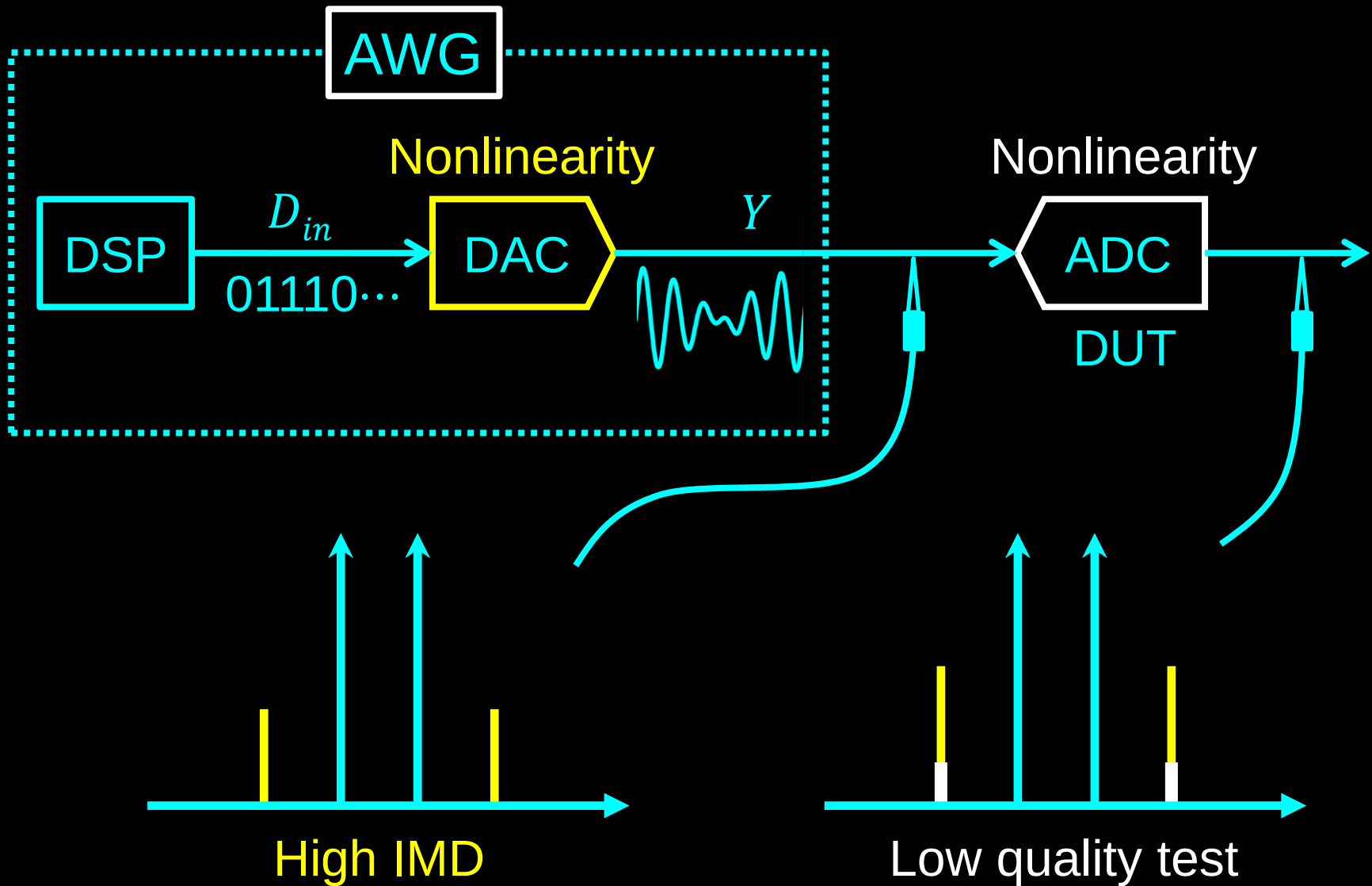
Cannot test nonlinearity of ADC

Two-tone test signal



Can test nonlinearity of ADC

Two-Tone Signal Generation with AWG



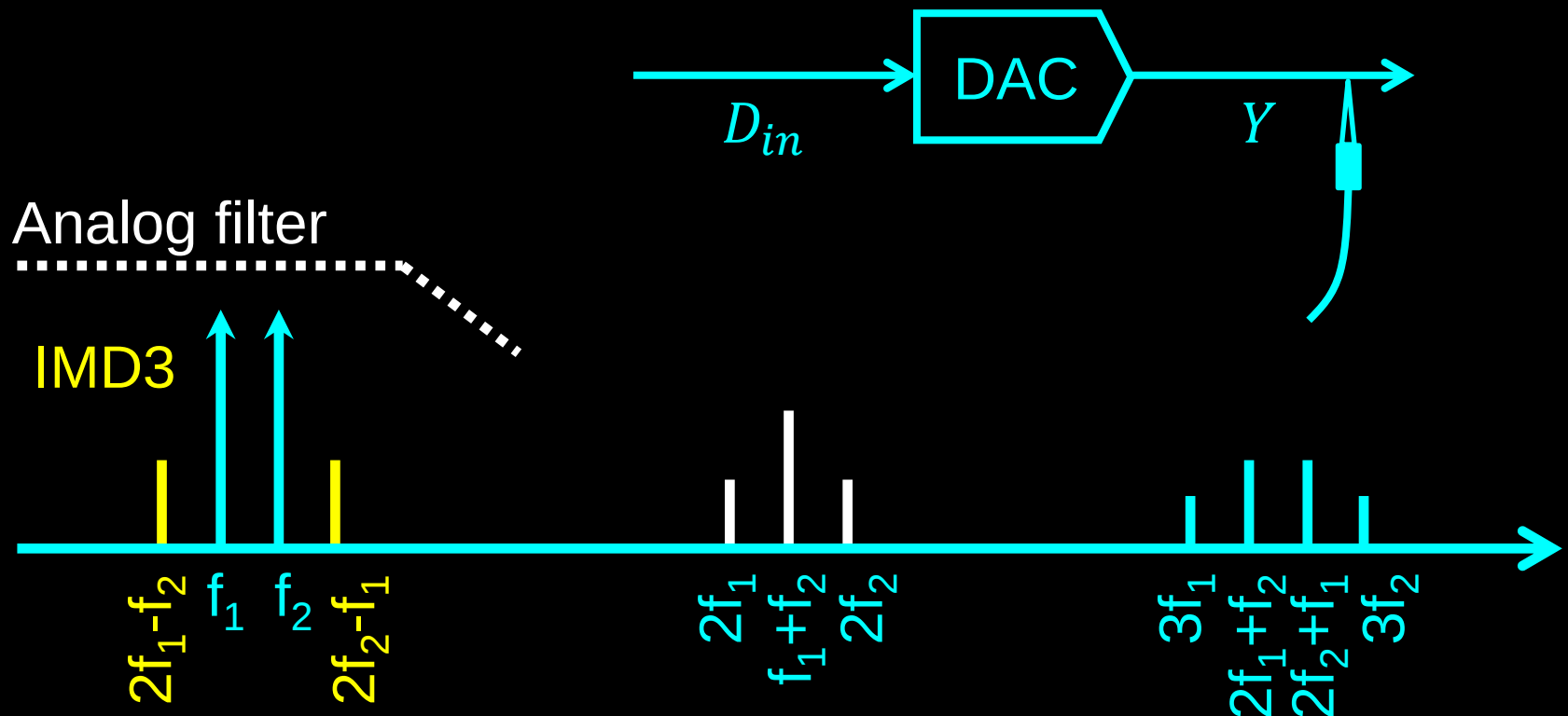
Distortion by Nonlinearity DAC

Ideal DAC

$$Y = a_1 D_{in}$$

Actual DAC

$$Y = a_0 + a_1 D_{in} + a_2 D_{in}^2 + a_3 D_{in}^3 + \dots$$

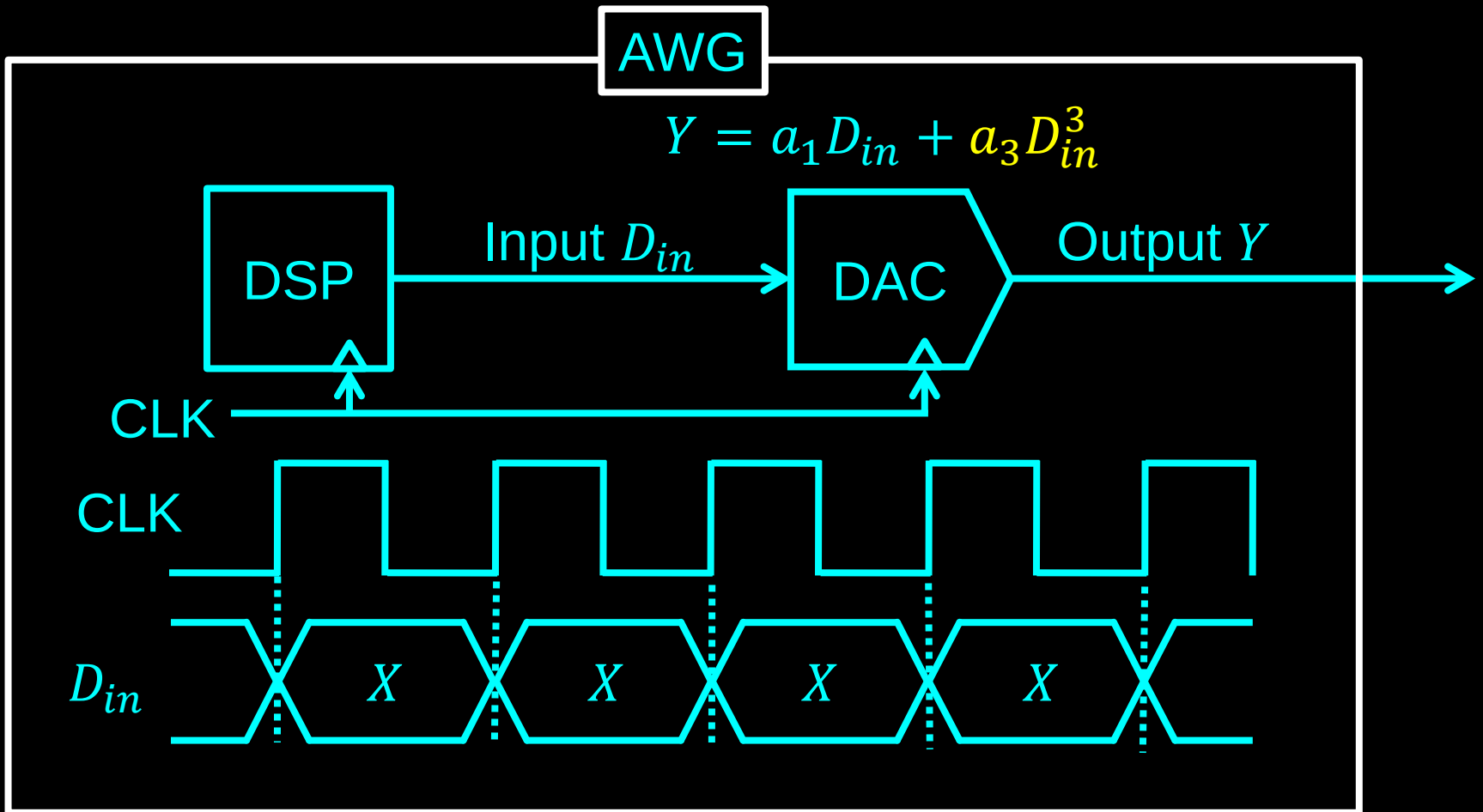


Cannot remove IMD3 with analog filter

Outline

- Conventional Method

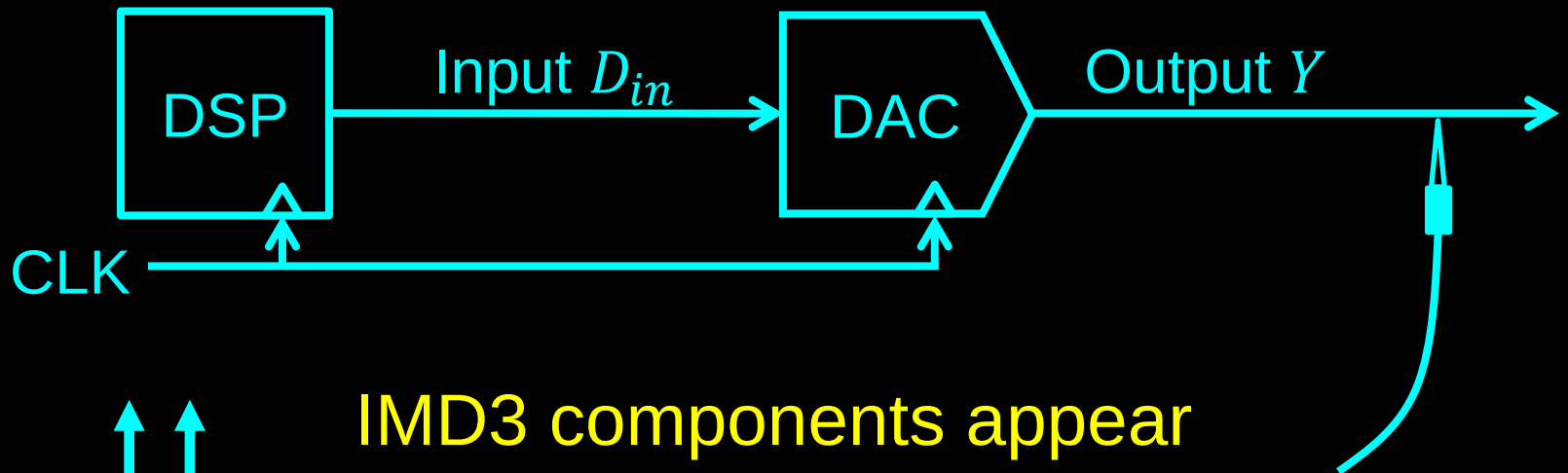
Conventional Method



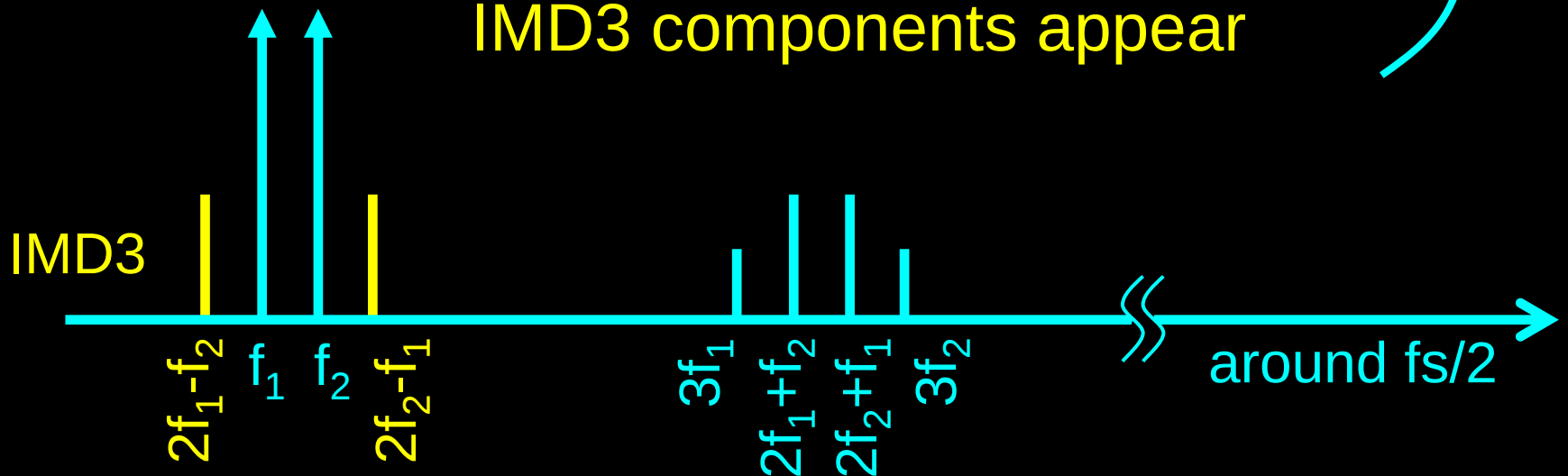
$$X = A \cdot \sin(2\pi f_1 n T_s) + B \cdot \sin(2\pi f_2 n T_s)$$

Conventional Method

$$Y = a_1 D_{in} + a_3 D_{in}^3$$



IMD3 components appear



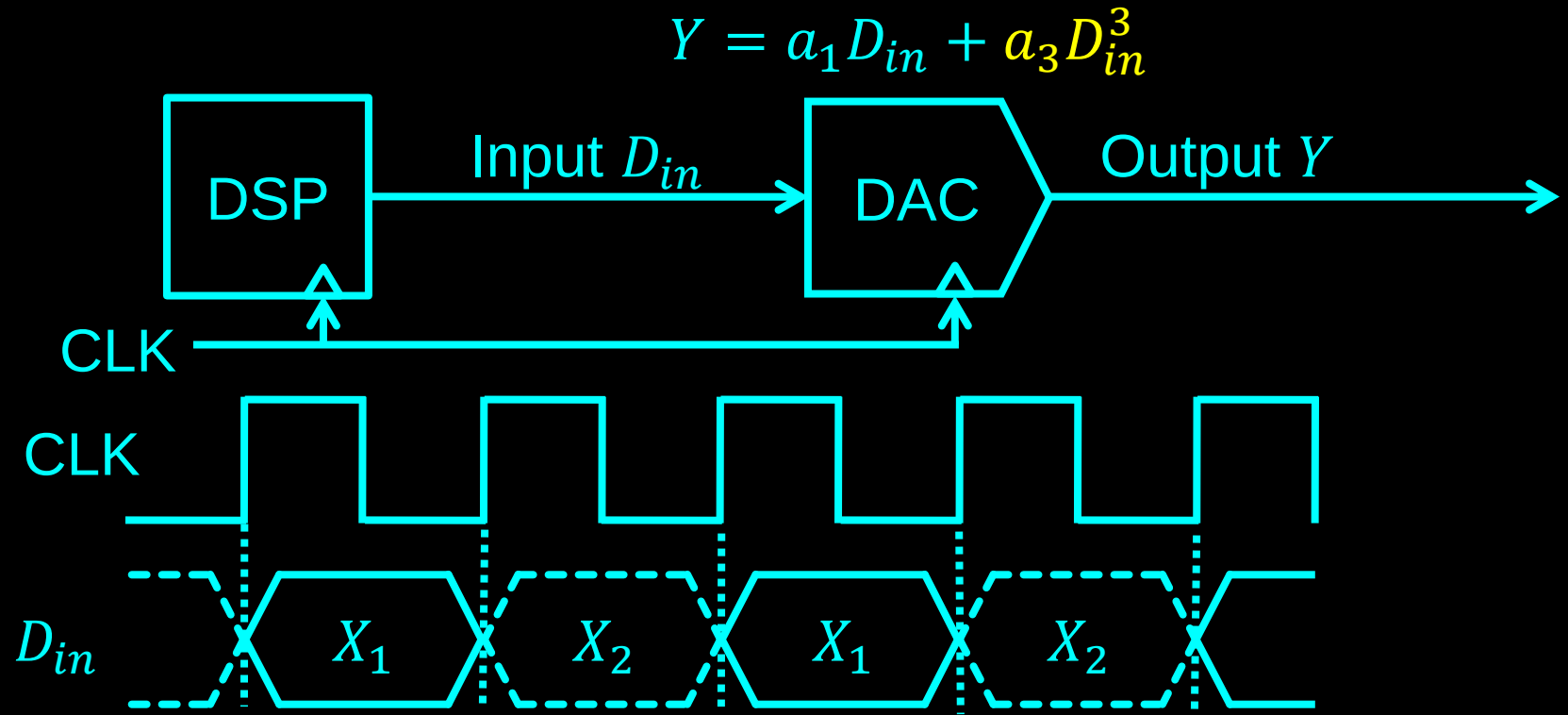
Outline

- Proposed Method

Proposed Method

- Phase Switching
- Frequency Switching
- Combination of Phase & Frequency Switching

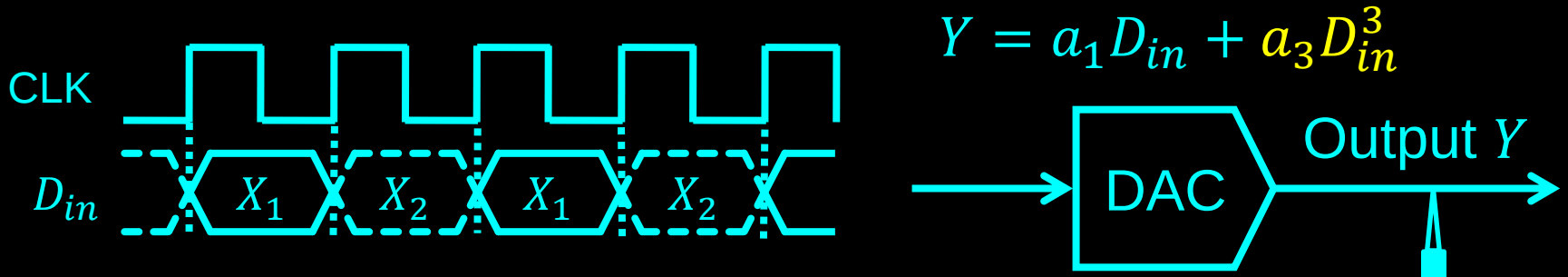
Phase Switching



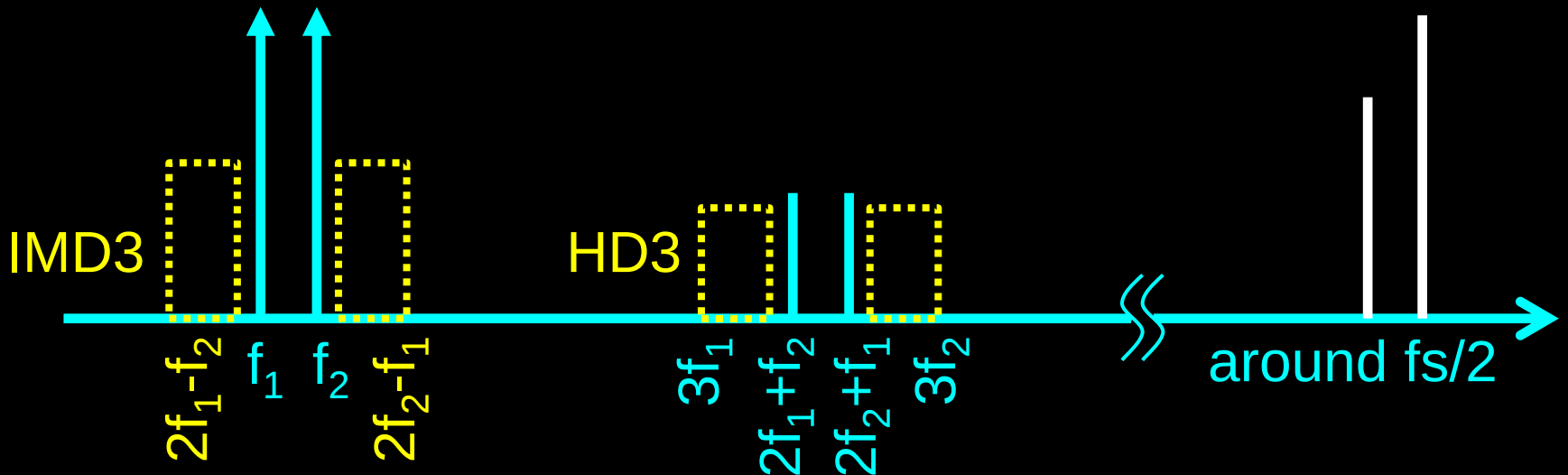
$$X_1 = A \cdot \sin\left(2\pi f_1 n T_s + \frac{\pi}{6}\right) + B \cdot \sin\left(2\pi f_2 n T_s - \frac{\pi}{6}\right)$$

$$X_2 = A \cdot \sin\left(2\pi f_1 n T_s - \frac{\pi}{6}\right) + B \cdot \sin\left(2\pi f_2 n T_s + \frac{\pi}{6}\right)$$

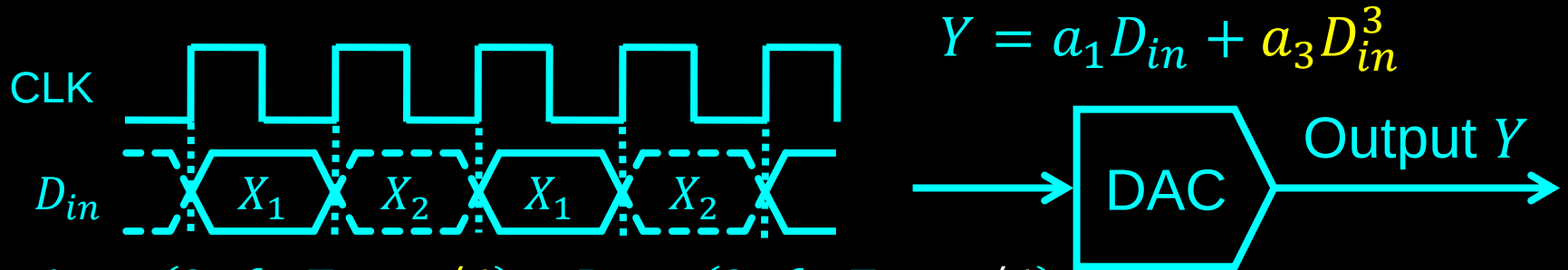
Phase Switching Effects



- Cancel IMD3 components
- Switching spurious appear

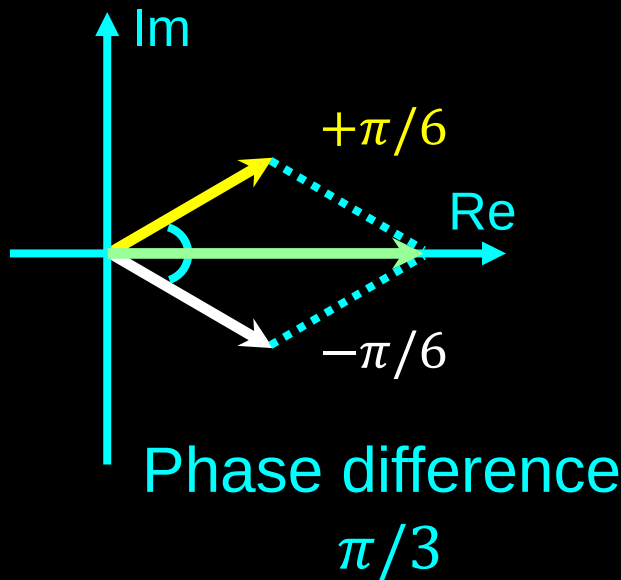


Principle of Phase Switching

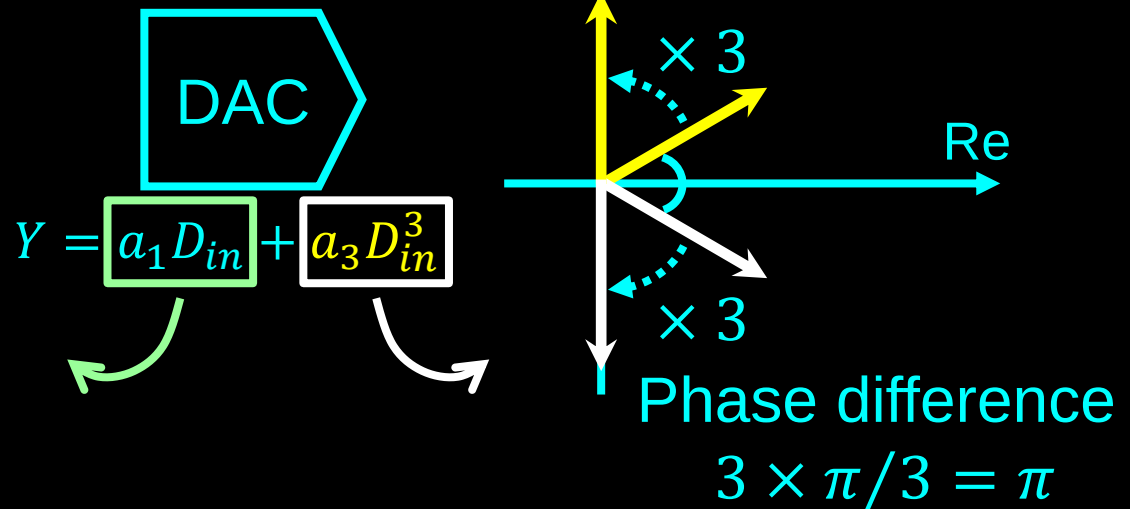


$$X_1 = A \cdot \sin(2\pi f_1 n T_s + \pi/6) + B \cdot \sin(2\pi f_2 n T_s - \pi/6)$$

$$X_2 = A \cdot \sin(2\pi f_1 n T_s - \pi/6) + B \cdot \sin(2\pi f_2 n T_s + \pi/6)$$

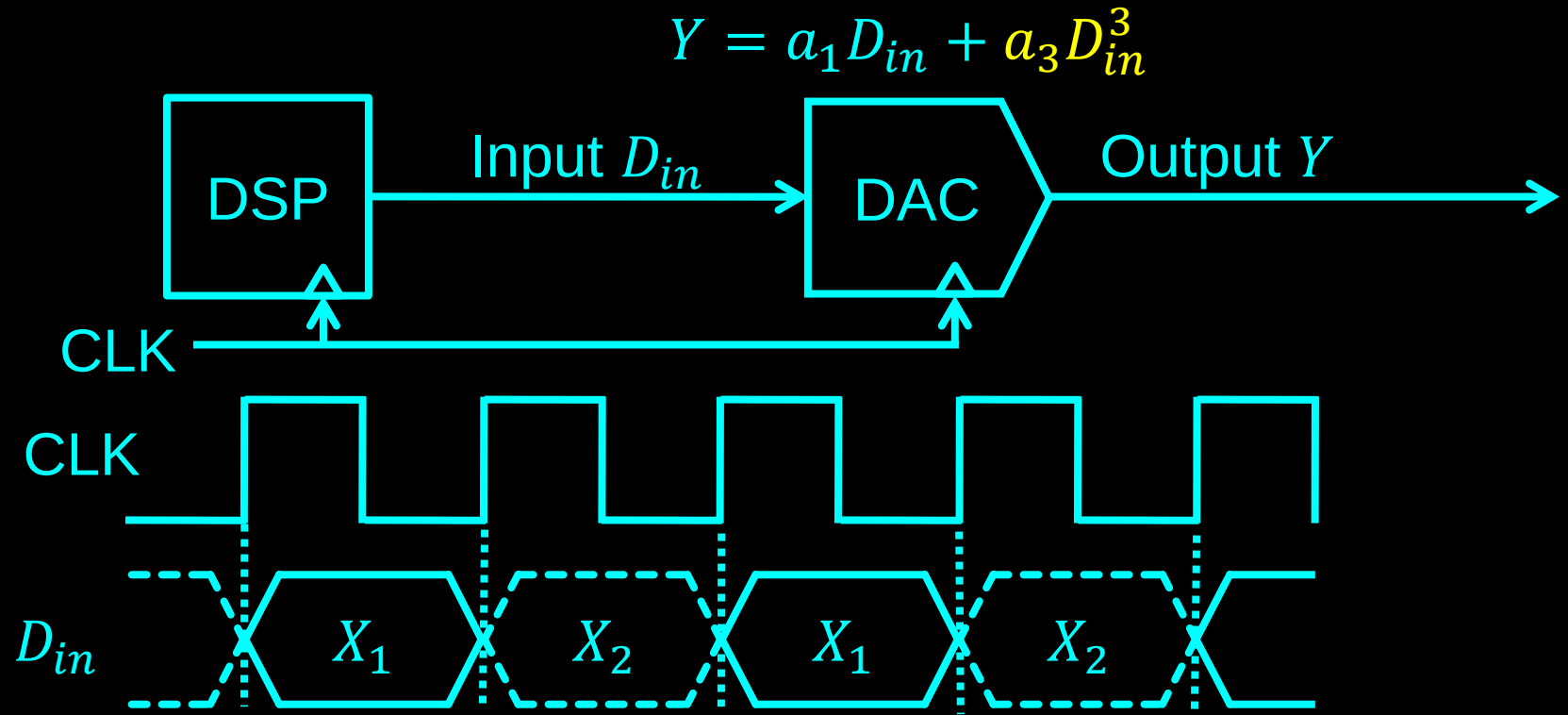


Fundamental component



Distortion component

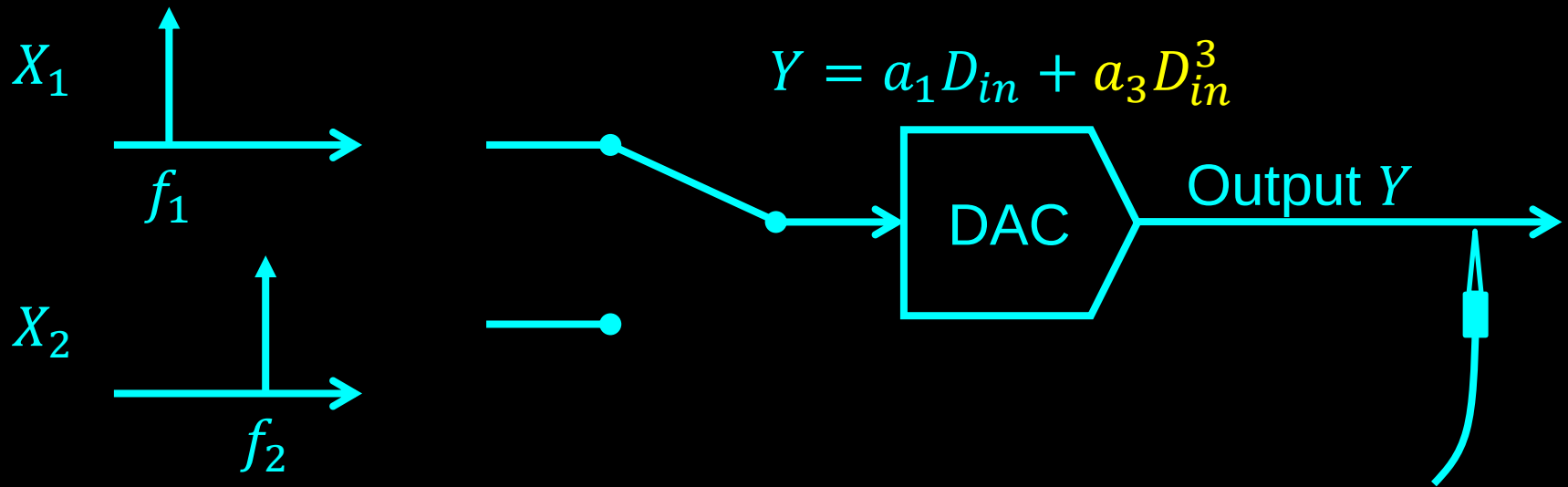
Frequency Switching



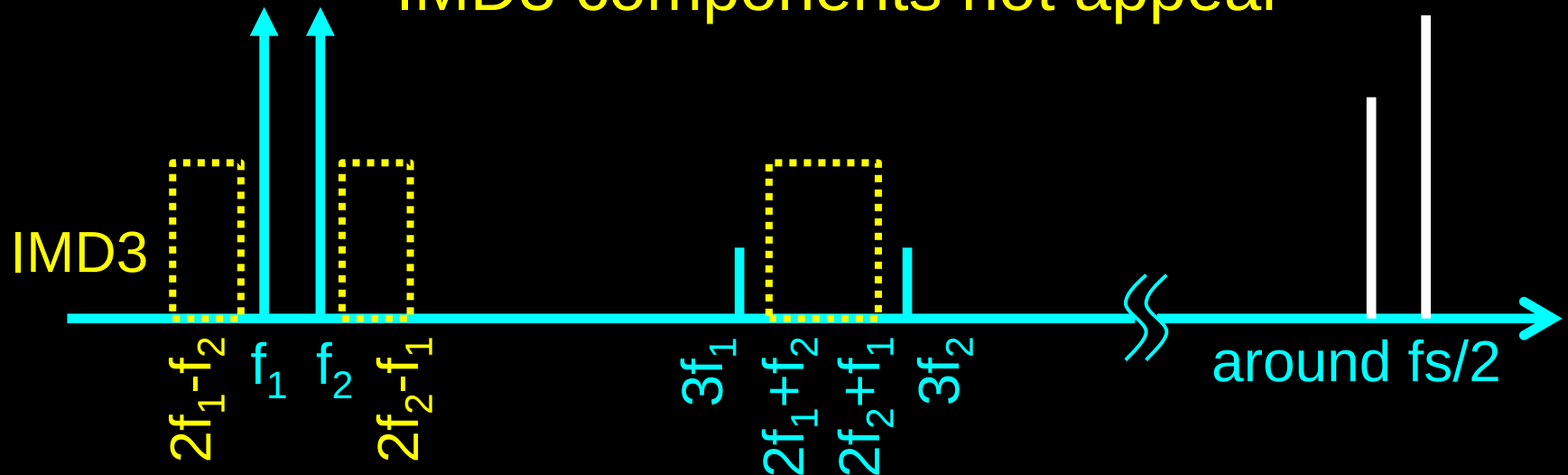
$$X_1 = A \cdot \sin(2\pi f_1 n T_s)$$

$$X_2 = B \cdot \sin(2\pi f_2 n T_s)$$

Frequency Switching Effects

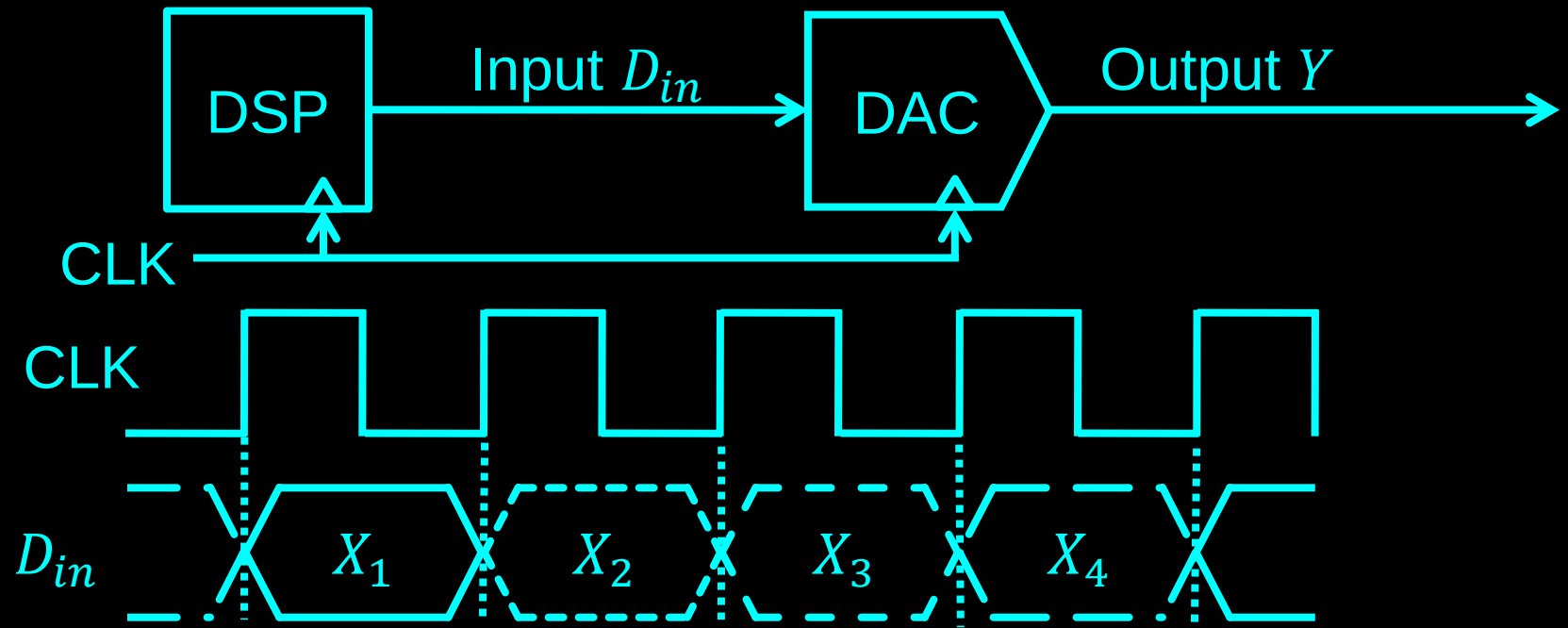


IMD3 components not appear



Combination of Phase & Frequency Switching

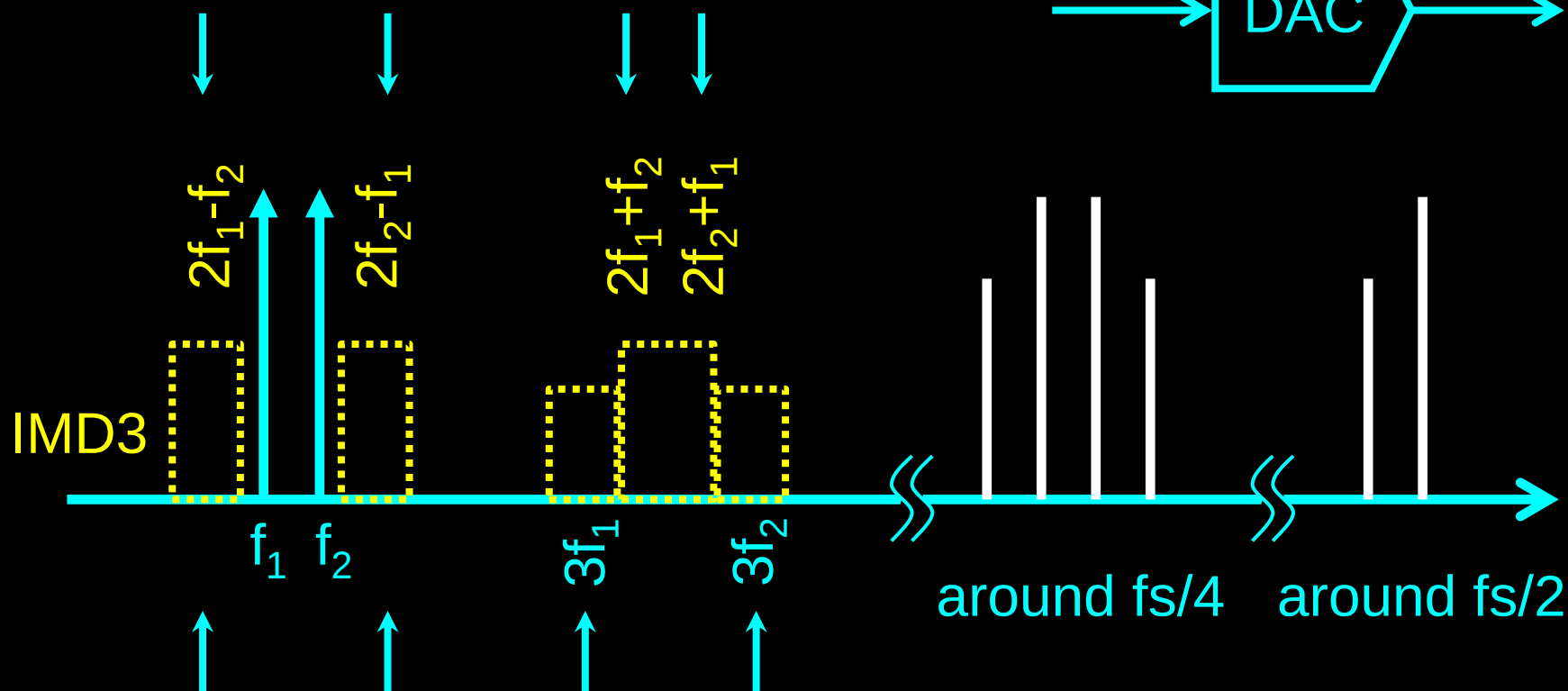
$$Y = a_1 D_{in} + a_3 D_{in}^3$$



$$\begin{aligned} X_1 &= A \cdot \sin\left(2\pi f_1 n T_s + \frac{\pi}{6}\right) & X_2 &= B \cdot \sin\left(2\pi f_2 n T_s - \frac{\pi}{6}\right) \\ X_3 &= A \cdot \sin\left(2\pi f_1 n T_s - \frac{\pi}{6}\right) & X_4 &= B \cdot \sin\left(2\pi f_2 n T_s + \frac{\pi}{6}\right) \end{aligned}$$

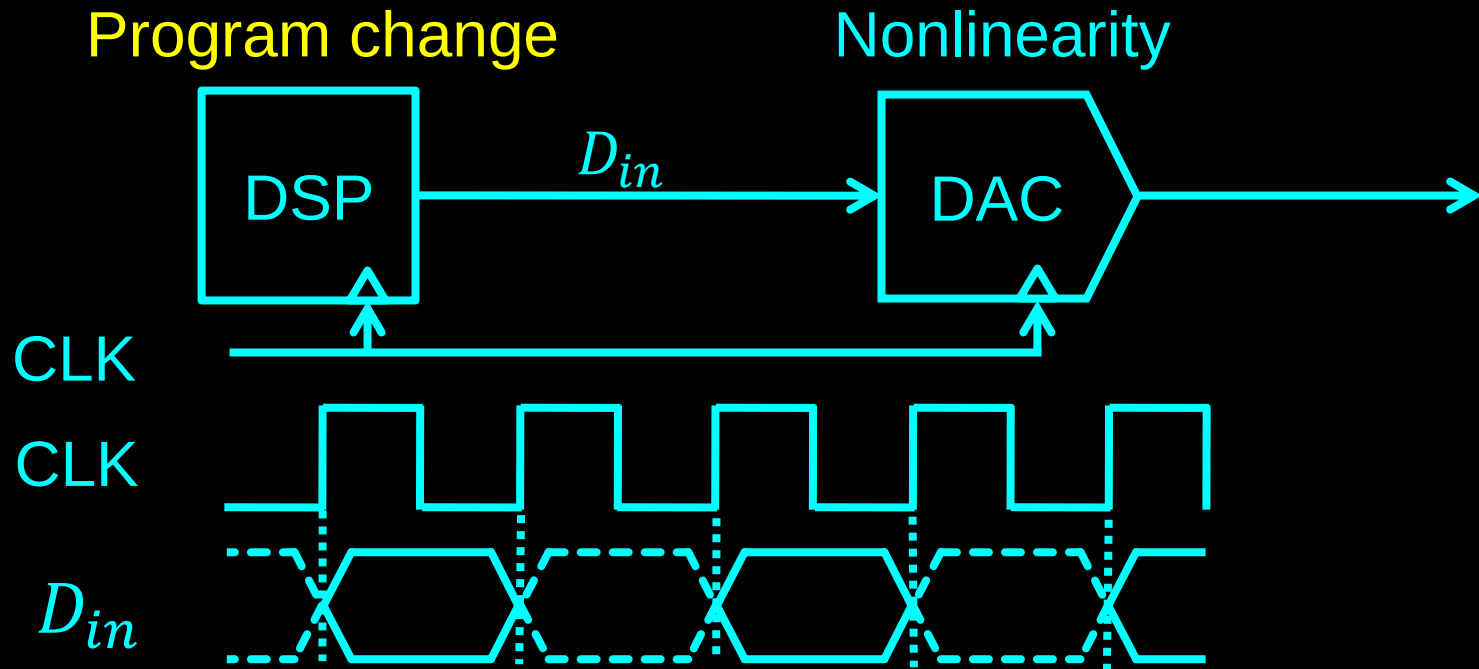
Phase & Frequency Switching Effects

Canceled by frequency switching



Canceled by phase switching

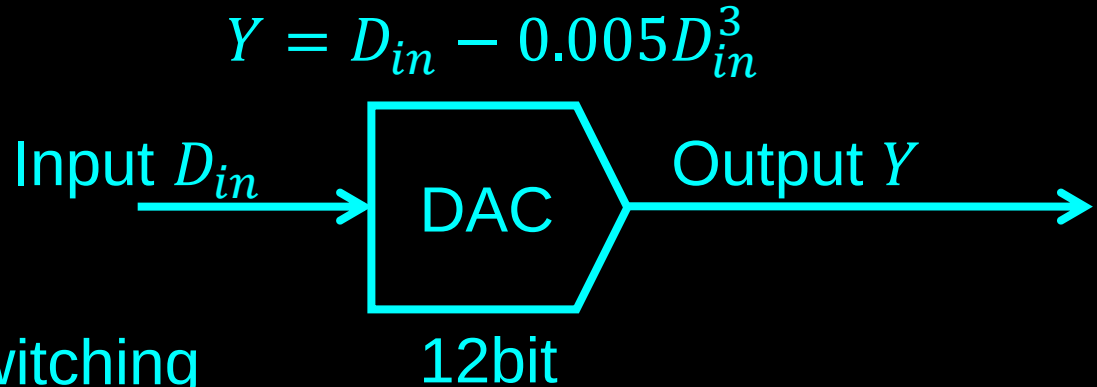
Merit of Proposed Methods



- No need for the DAC nonlinearity identification
 - No need for calibration
- Only DSP program change
 - No hardware change

Simulation Condition

- Conventional
- Proposed
 - Phase switching
 - Frequency switching
 - Phase & Frequency switching

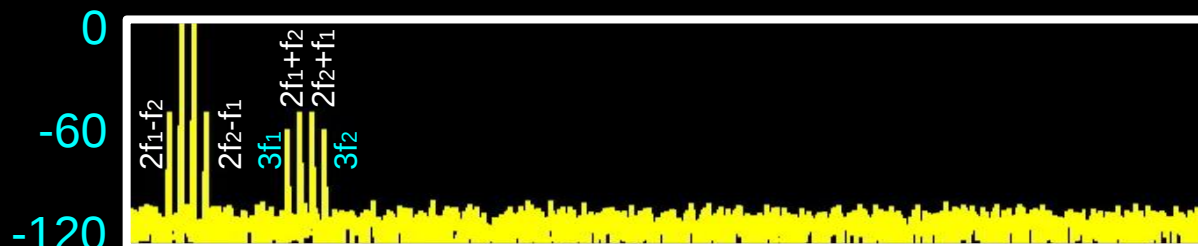


Input frequency f_1	99
Input frequency f_2	122
Amplitude	1
Sampling frequency	4000

Simulation by Matlab

Phase, Frequency, Phase Freq. Switching

Conventional



Phase Switching

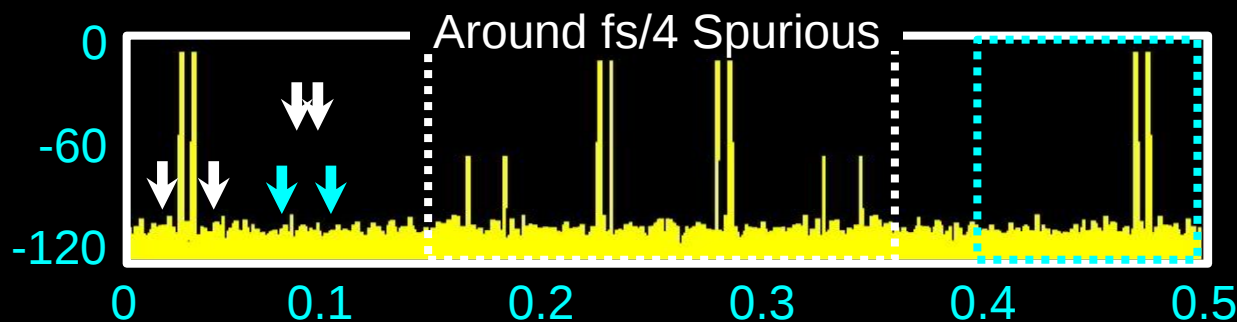


Around $f_s/2$ Spurious

Frequency Switching



Phase & Frequency Switching



Normalized Frequency f/f_s

Outline

- Experimental Results

Experimental Condition

AWG

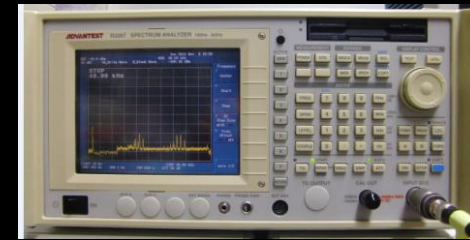


Agilent 33220A

Signal



Spectrum analyzer



ADVANTEST R3267

Frequency range	1uHz to 6MHz
Amplitude resolution	14bit
Max sampling rate	50MSa/s

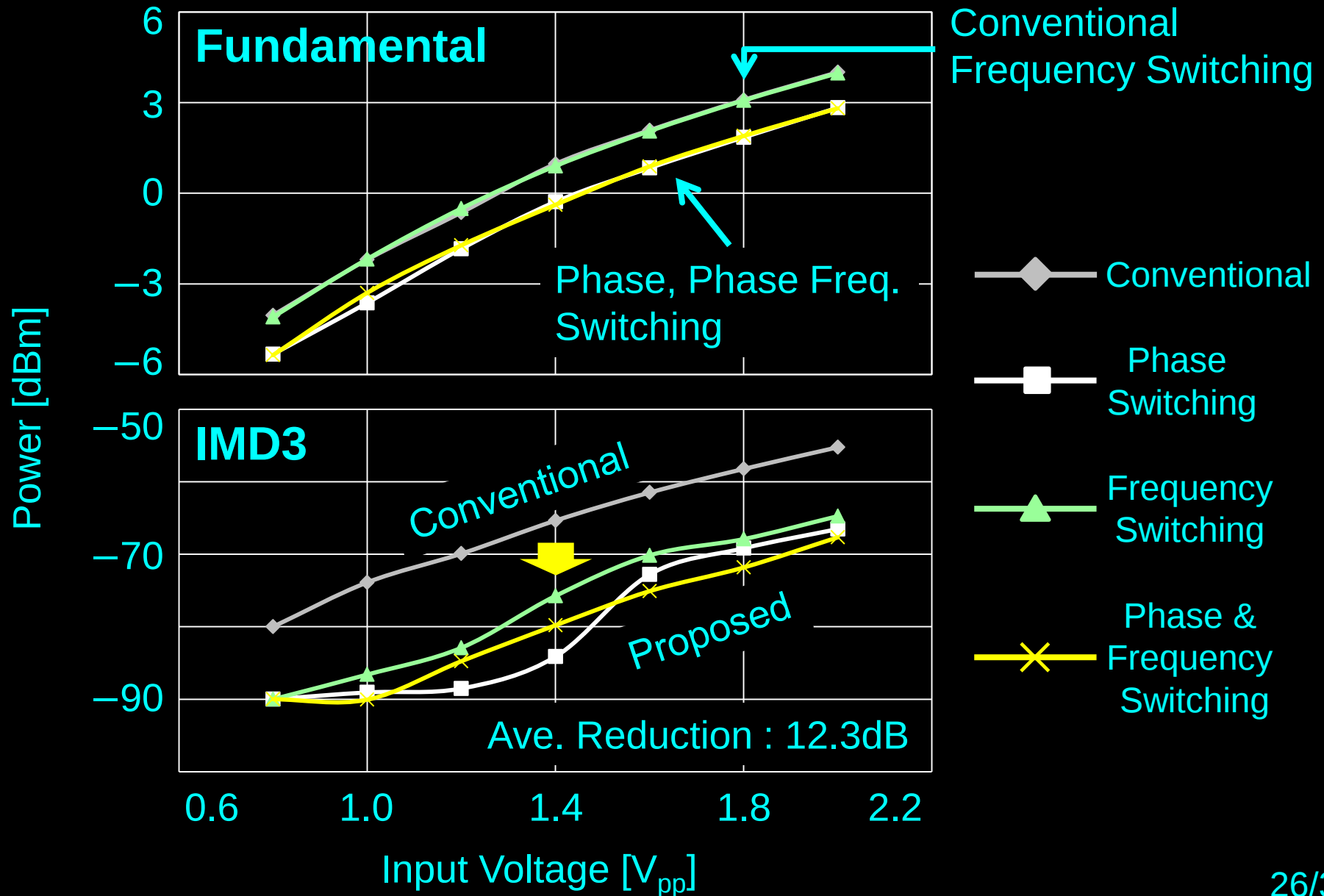
Frequency range	100Hz to 8GHz
RBW	10Hz to 30MHz

※ RBW : Resolution Band Width

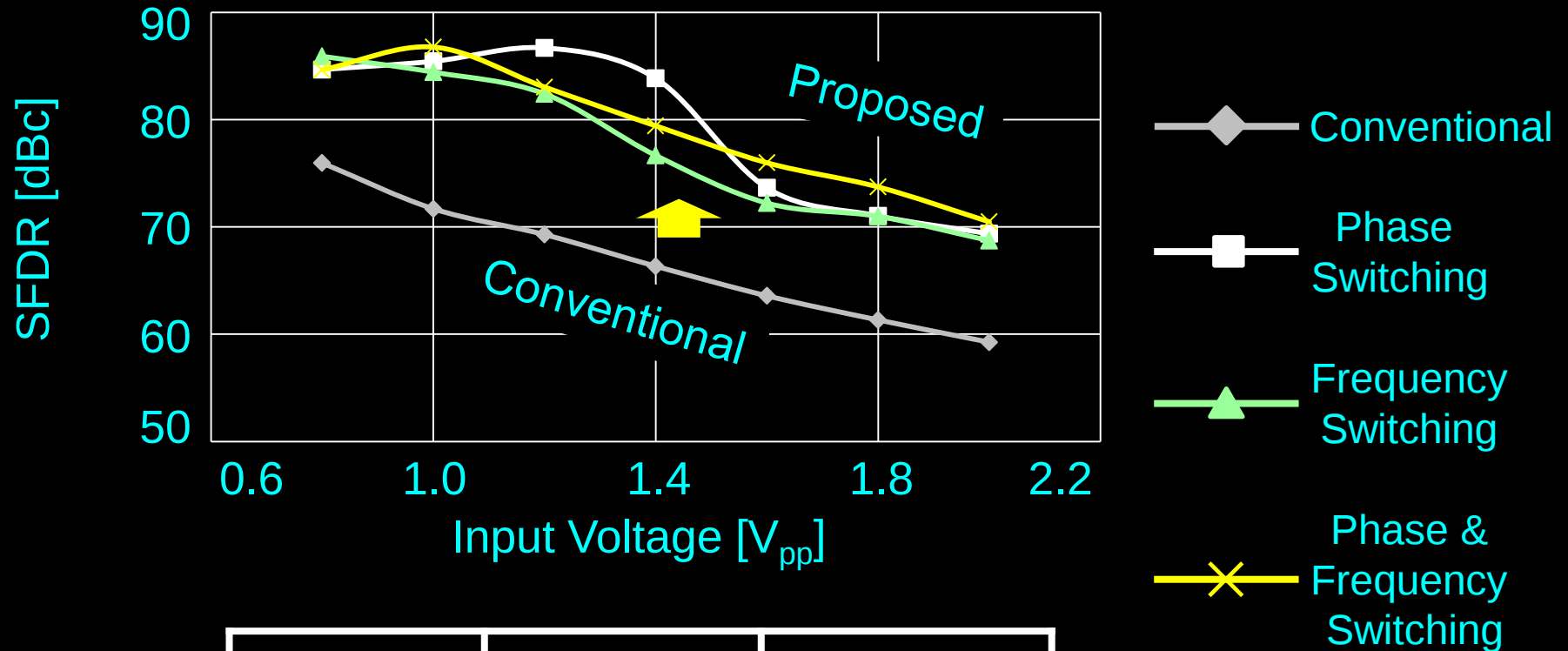
Test Signal

Two-tone signal	200kHz , 220kHz
Sampling rate	10MSa/s
Input voltage	0.8 to 2.0V _{pp} (0.2V step)

Experimental Results



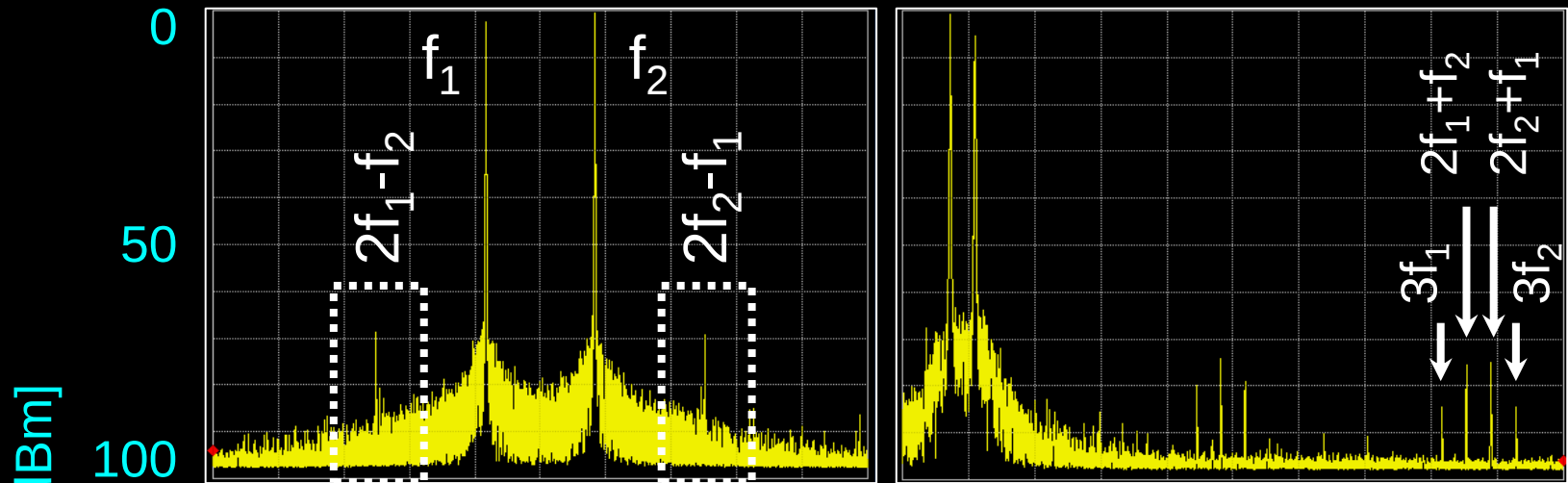
SFDR Improvement



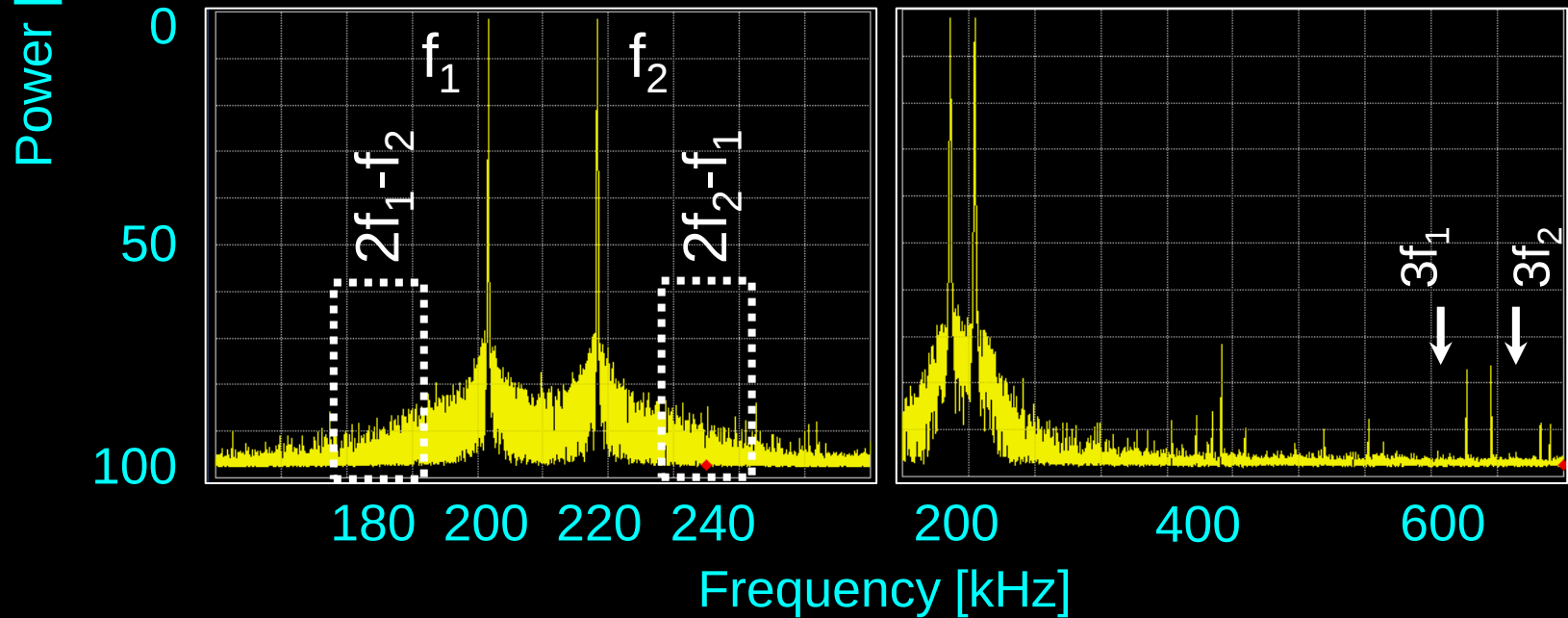
Phase Switching	Frequency Switching	Phase & Frequency Switching
+12.5 dB	+10.6 dB	+12.4 dB

Phase Switching

Conventional

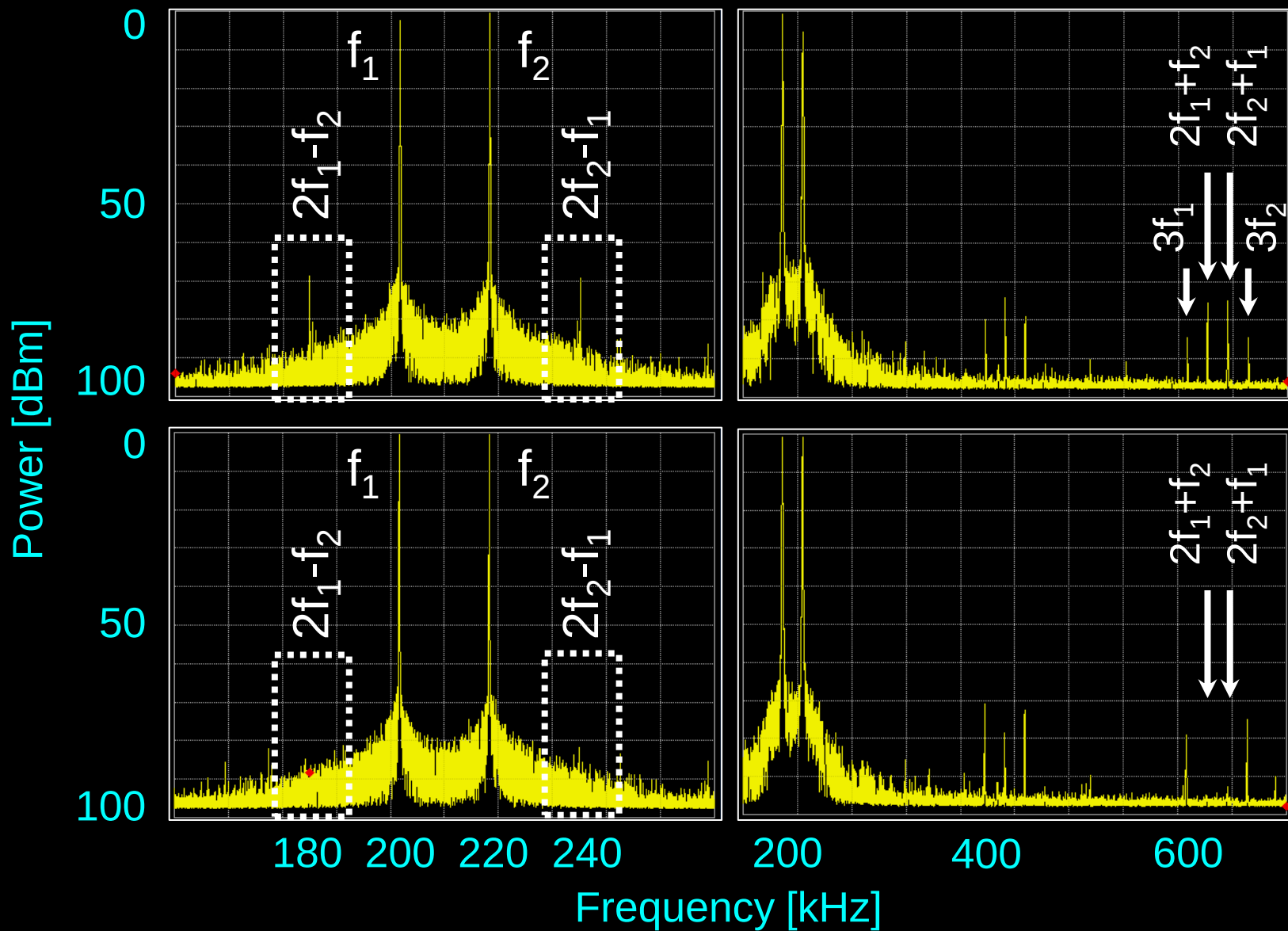


Phase Switching



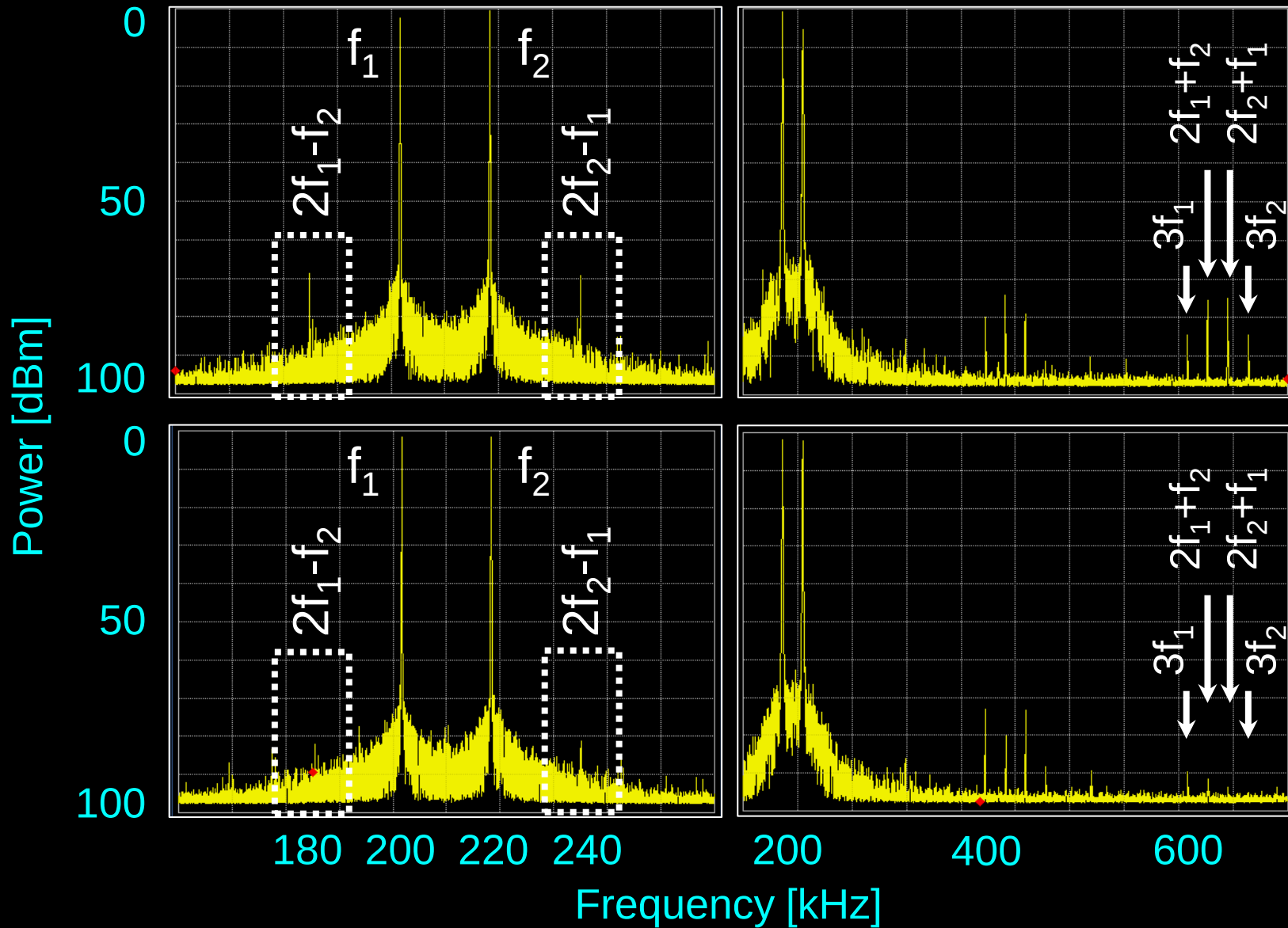
Frequency Switching

Frequency Switching Conventional



Phase & Frequency Switching

Phase & Frequency Switching



Outline

- Conclusion

Conclusion

- For low distortion two-tone signal generation with low-cost AWG
 - Proposed 3 methods
 - No need for the DAC nonlinearity identification
 - Only DSP program change
 - No hardware change, no calibration
- Effectiveness of our proposed methods
 - Verified by simulation, and experimental results
 - IMD3 reduction and SFDR improvement

Question

Q : 今後の課題、どのようなアプリケーション

Q : 3トーン、4トーンに応用すると分解能はどうなるか

C : IMD3の取り方がいいがSFDRの取り方が良くない。
スカートを持つような図にするべき

Presented by Keisuke Kato

